Search Notes

Application/Control No.	Applicant(s)/Patent unde Reexamination	Applicant(s)/Patent under Reexamination	
10/764,452	MURATA ET AL.		
Examiner	Art Unit		
Tuan H. Le	2622		

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Class	Subclass	Date	Examiner
348	218.1,219. 1	3/19/2007	ΤŁ
348	272-280	3/16/2007	TL
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
inventor name search	3/16/2007	TL		
US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB	3/16/2007	TL		